

## EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	129348	(lap\$4 grind\$3 thin\$4 polish\$3 etch\$3) with wafer\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:50
L2	3549	1 and (bump\$3 with (solder\$3 electrode\$1))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:37
L3	2170	2 and ((dic\$3 singulat\$4 separat\$4 divid\$3 cut\$4) with (chip\$1 die\$1))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:37
L5	233	3 and ((heat thermal) with (Cu copper))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:38
L9	779	1 same (bump\$3 with (solder\$3 electrode\$1))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:37
L10	385	9 and ((dic\$3 singulat\$4 separat\$4 divid\$3 cut\$4) with (chip\$1 die\$1))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:37
L11	30	10 and ((heat thermal) with (Cu copper))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/02/19 22:38